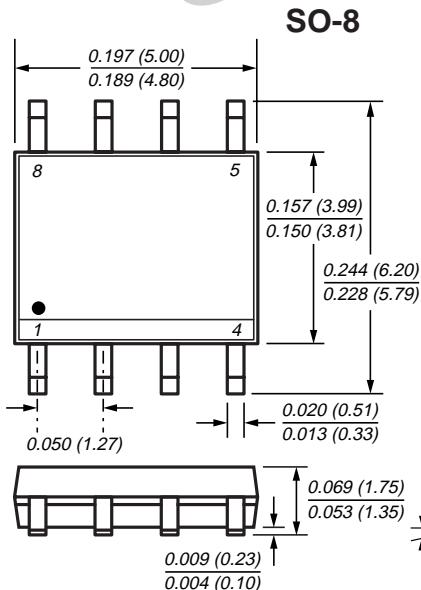




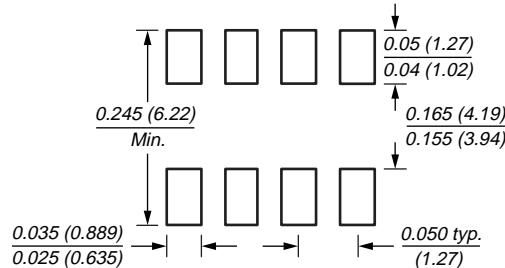
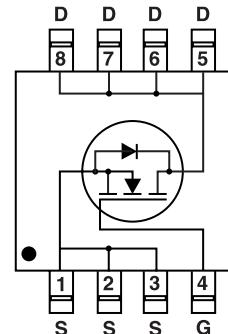
TRENCH
GENFET®

N-Channel Enhancement-Mode MOSFET

V_{DS} 60V R_{DS(ON)} 24mΩ I_D 7.5A



New Product



Mounting Pad Layout

Mechanical Data

Case: SO-8 molded plastic body

Terminals: Leads solderable per MIL-STD-750, Method 2026

High temperature soldering guaranteed:
250°C/10 seconds at terminals

Mounting Position: Any

Weight: 0.5g

Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for Low Voltage DC/DC Converters
- Fast Switching for High Efficiency

Maximum Ratings and Thermal Characteristics (T_A = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	60	V
Gate-Source Voltage	V _{GS}	±20	
Continuous Drain Current ⁽¹⁾	I _D	7.5	A
Pulsed Drain Current	I _{DM}	50	
Maximum Power Dissipation ⁽¹⁾ T _A = 25°C T _A = 70°C	P _D	2.5 1.6	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150	°C
Junction-to-Ambient Thermal Resistance ⁽¹⁾	R _{θJA}	50	°C/W

Note: (1) Surface Mounted on FR4 Board, t ≤ 10s

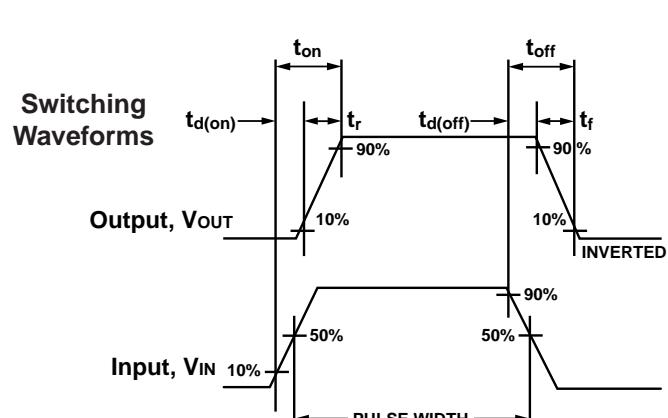
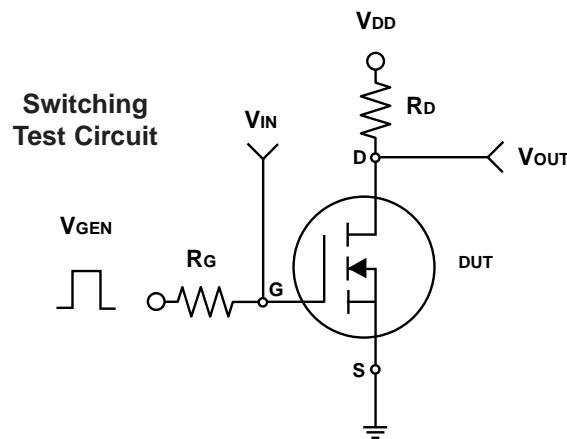
N-Channel Enhancement-Mode MOSFET

Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$	60	—	—	V
Gate Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$	2.0	—	—	V
Gate-Body Leakage	I_{GSS}	$\text{V}_{\text{DS}} = 0\text{V}, \text{V}_{\text{GS}} = \pm 20\text{V}$	—	—	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$\text{V}_{\text{DS}} = 60\text{V}, \text{V}_{\text{GS}} = 0\text{V}$	—	—	1.0	μA
On-State Drain Current ⁽²⁾	$\text{I}_{\text{D(on)}}$	$\text{V}_{\text{DS}} \geq 5\text{V}, \text{V}_{\text{GS}} = 10\text{V}$	20	—	—	A
Drain-Source On-State Resistance ⁽²⁾	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 7.5\text{A}$	—	12	24	$\text{m}\Omega$
		$\text{V}_{\text{GS}} = 6.0\text{V}, \text{I}_D = 6.5\text{A}$	—	14	30	
Forward Transconductance ⁽²⁾	g_{fs}	$\text{V}_{\text{DS}} = 15\text{V}, \text{I}_D = 7.5\text{A}$	—	36	—	S
Dynamic						
Total Gate Charge	Q_g	$\text{V}_{\text{DS}} = 30\text{V}, \text{V}_{\text{GS}} = 10\text{V}$ $\text{I}_D = 7.5\text{A}$	—	65	91	nC
Gate-Source Charge	Q_{gs}		—	12	—	
Gate-Drain Charge	Q_{gd}		—	14	—	
Turn-On Delay Time	$t_{\text{d(on)}}$	$\text{V}_{\text{DD}} = 30\text{V}, \text{R}_L = 30\Omega$ $\text{I}_D \approx 1\text{A}, \text{V}_{\text{GEN}} = 10\text{V}$ $\text{R}_G = 6\Omega$	—	17	30	ns
Rise Time	t_r		—	13	20	
Turn-Off Delay Time	$t_{\text{d(off)}}$		—	78	117	
Fall Time	t_f		—	31	40	
Input Capacitance	C_{iss}	$\text{V}_{\text{GS}} = 0\text{V}$ $\text{V}_{\text{DS}} = 30\text{V}$ $f = 1.0\text{MHz}$	—	3147	—	pF
Output Capacitance	C_{oss}		—	283	—	
Reverse Transfer Capacitance	C_{rss}		—	140	—	
Source-Drain Diode						
Diode Forward Voltage	V_{SD}	$\text{I}_S = 2.1\text{A}, \text{V}_{\text{GS}} = 0\text{V}$	—	0.71	1.2	V
Max. Diode Forward Current	I_S		—	—	2.1	A

Notes: (1) Surface Mounted on FR4 Board, $t \leq 10\text{s}$

(2) Pulse test; pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$



N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves (TA = 25°C unless otherwise noted)

Fig. 1 – Output Characteristics

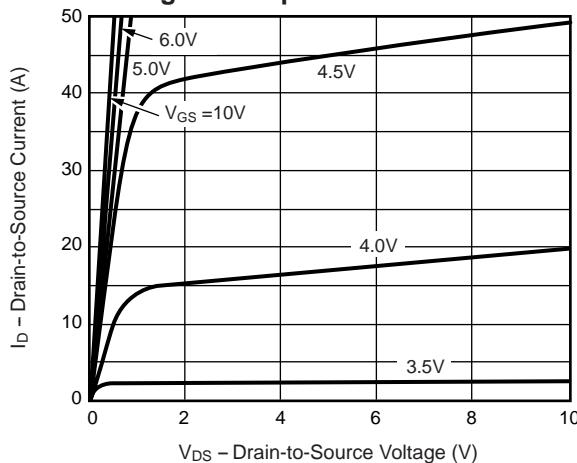


Fig. 2 – Transfer Characteristics

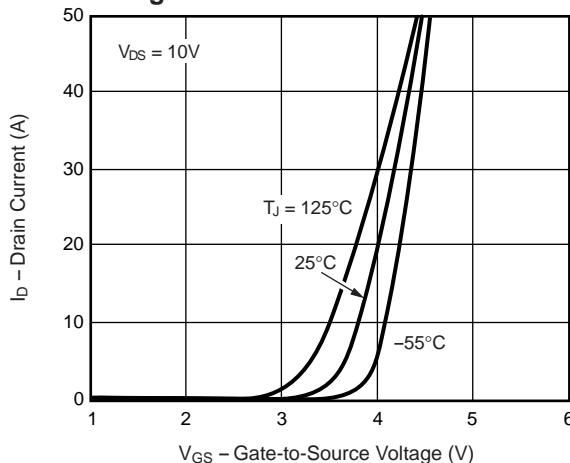


Fig. 3 – Threshold Voltage vs. Temperature

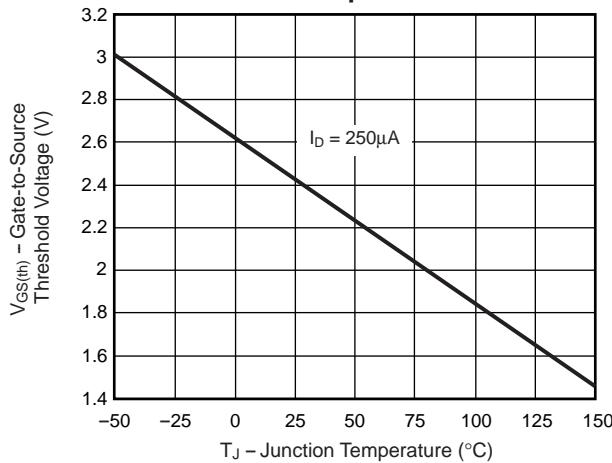


Fig. 4 – On-Resistance vs. Drain Current

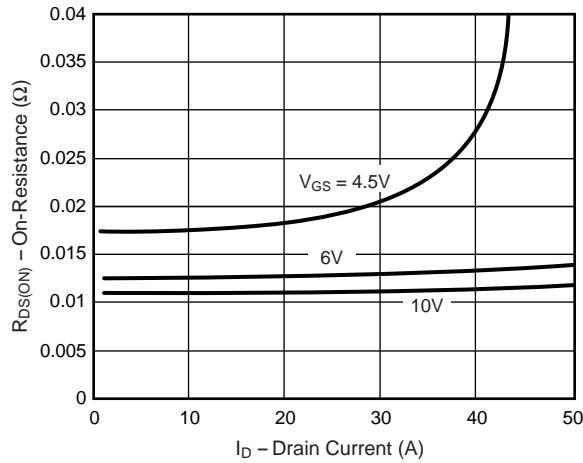
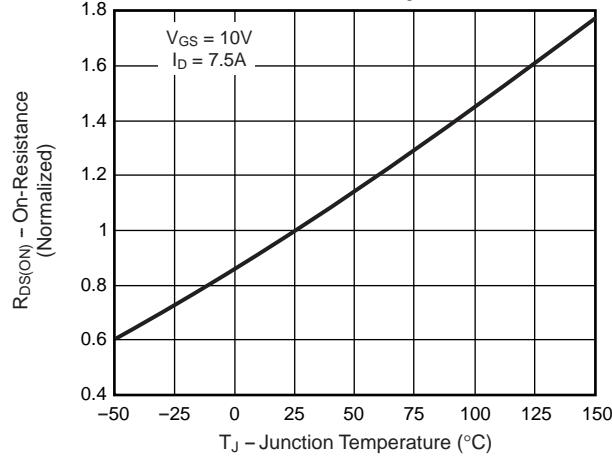


Fig. 5 – On-Resistance vs. Junction Temperature



N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves (T_A = 25°C unless otherwise noted)

Fig. 6 – On-Resistance vs. Gate-to-Source Voltage

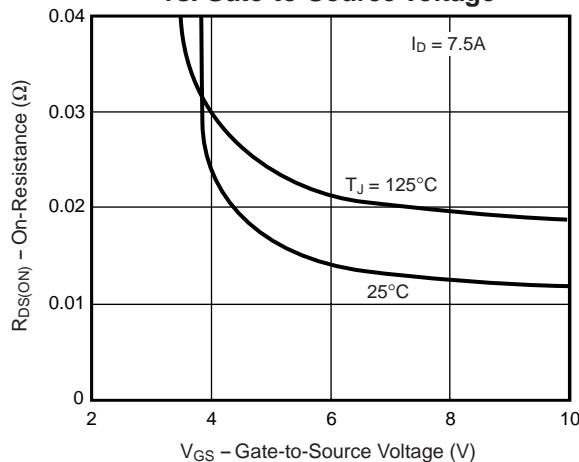


Fig. 7 – Gate Charge

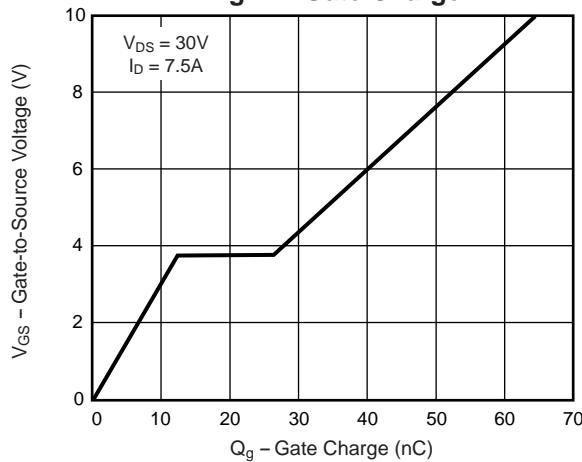


Fig. 8 – Capacitance

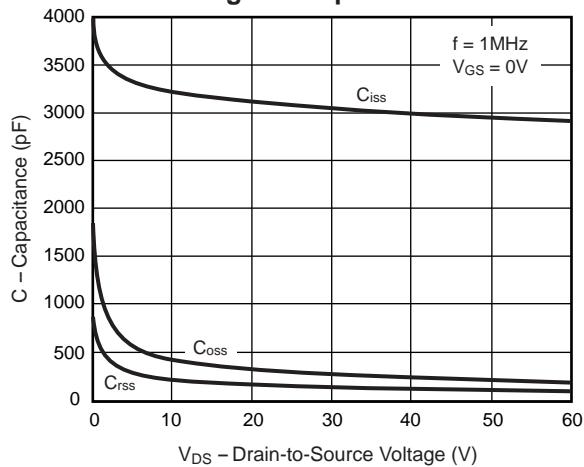
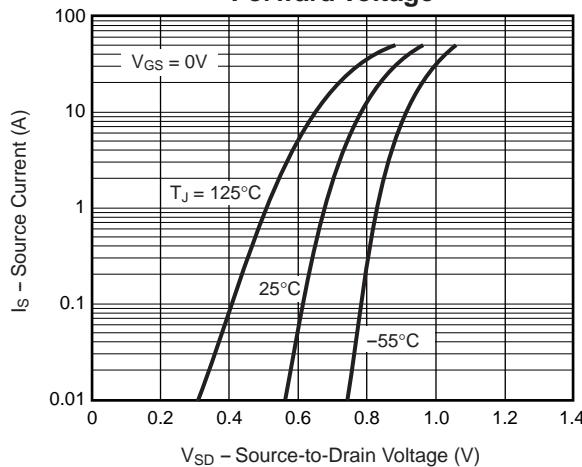


Fig. 9 – Source-Drain Diode Forward Voltage



N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves ($TA = 25^\circ\text{C}$ unless otherwise noted)

Fig. 10 – Breakdown Voltage vs. Junction Temperature

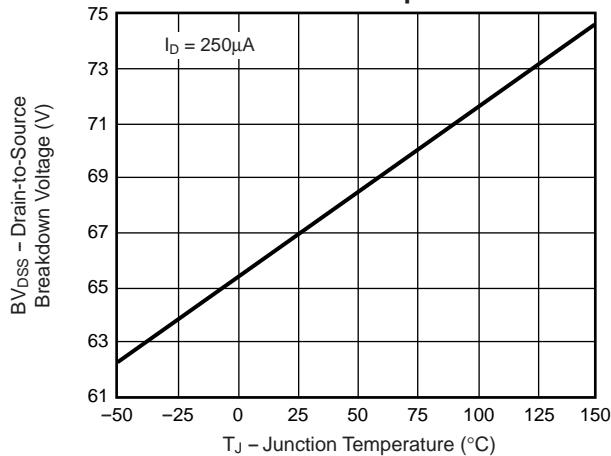


Fig. 12 – Power vs. Pulse Duration

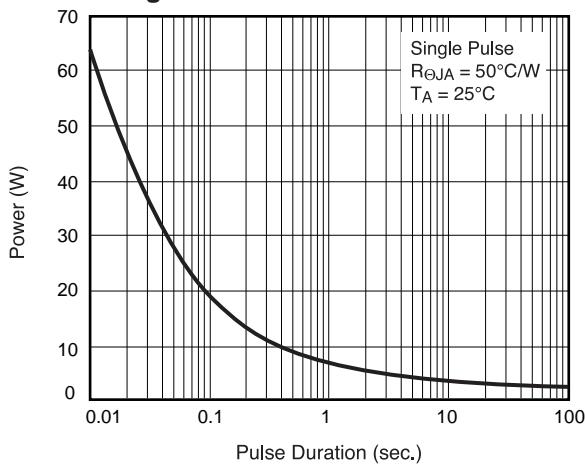


Fig. 11 – Transient Thermal Impedance

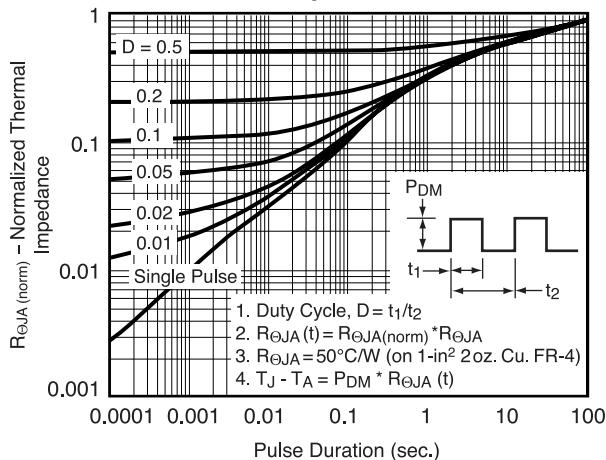


Fig. 13 – Maximum Safe Operating Area

